**SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT**

Applicant : Bogdan C. Maglich
App. No. : 09/883,851
Filed : June 18, 2001
For : METHOD AND APPARATUS FOR
NEUTRON MICROSCOPY WITH
STOICHIOMETRIC IMAGING
Examiner : Jack W. Keith
Group Art Unit : 3641

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

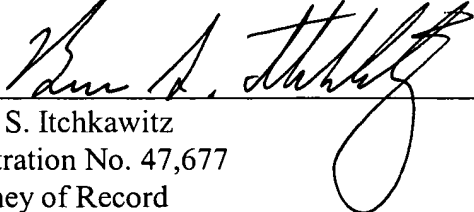
Enclosed is form PTO-1449 listing twelve (12) references that are of record in U.S. patent application No. 09/788,736, filed February 20, 2001, which is the parent of this continuation-in-part application, and is relied upon for an earlier filing date under 35 U.S.C. § 120. Copies of the references are not submitted pursuant to 37 C.F.R. § 1.98(d).

This Supplemental Information Disclosure Statement is being filed with an RCE or within three months of the filing date of this application and no fee is required in accordance with 37 C.F.R. § 1.97(b)(1), (b)(2), or (b)(4).

Respectfully submitted,

KNOBBE, MARTENS, OLSON & BEAR, LLP

Dated: 2/12/04

By: 
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FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
HIENER.1CPC1CPAPPLICATION NO.
09/883,851SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT
BY APPLICANTAPPLICANT
Bogdan C. MaglichFILING DATE
June 18, 2001GROUP
3641

USE SEVERAL SHEETS IF NECESSARY)

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)
	1	6,297,507 B1	10/02/01	Chen et al.			

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
	2	WO 96/13839	05/09/96	PCT			YES	NO

EXAMINER INITIAL	OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)	
	3	Ed Rhodes et al., <i>Associated-Particle Sealed-Tube Neutron Probe for Characterization of Materials</i> , <u>PROCEEDINGS EUROPT SERIES</u> , SPIE Volume 2092, October 5-8, 1993, Innsbruck, Austria, pp. 288-300.
	4	George Vourvopoulos et al., <i>A Transportable, Neutron-Based Contraband Detection System</i> , <u>Proceedings: Counterdrug Law Enforcement: Applied Technology for Improved Operational Effectiveness, International Technology Symposium</u> , Part 1, October 24-27, 1995, Nashua, New Hampshire, pp. 2-39 through 2-48 (missing pages 2-45 and 2-46).
	5	Dr. Douglas Brown et al., <i>Cargo Inspection System Based on Pulsed Fast Neutron Analysis</i> , <u>Proceedings: Counterdrug Law Enforcement: Applied Technology for Improved Operational Effectiveness, International Technology Symposium</u> , Part 1, October 24-27, 1995, Nashua, New Hampshire, pp. 2-49 through 2-62.
	6	Bradley J. Micklich et al., <i>Narcotics Detection Using Fast-Neutron Interrogation</i> , <u>Proceedings: Counterdrug Law Enforcement: Applied Technology for Improved Operational Effectiveness, International Technology Symposium</u> , Part 1, October 24-27, 1995, Nashua, New Hampshire, pp. 2-63 through 2-72.
	7	Siraj M. Khan et al., <i>Review of Neutron-Based Technologies for the Inspection of Cargo Containers</i> , <u>Proceedings: Counterdrug Law Enforcement: Applied Technology for Improved Operational Effectiveness, International Technology Symposium</u> , Part 1, October 24-27, 1995, Nashua, New Hampshire, pp. 6-1 through 6-15.
	8	Tsahi Gozani, <i>Inspection Techniques Based on Neutron Interrogation</i> , <u>SPIE Proceedings: Physics-Based Technologies for the Detection of Contraband</u> , November 19-20, 1996, Boston, Massachusetts, pp. 9-20.
	9	Bogdan C. Maglich et al., <i>Demo of Chemically-Specific Non-Intrusive Detection of Cocaine Simulant by Fast Neutron Atometry</i> , <u>Proceedings: 1999 ONDCP International Technology Symposium</u> , March 8-10, 1999, Washington, D.C., pp. 9-12 through 9-22.
	10	Committee on Commercial Aviation Security, <i>Reducing the Risk of Explosives on Commercial Aircraft</i> , National Materials Advisory Board, Publication NMAB-463, National Academy Press, 1990, p. 31.
	11	Timothy R. Twomey, et al., <i>High-Count-Rate Spectroscopy with Ge Detectors: Quantitative Evaluation of the Performance of High-Rate Systems</i> , <u>Radioactivity and Radiochemistry</u> , Vol. 2, No. 3, 1991, pp. 28-48 (missing pages 29, 32, and 33).
	12	Canberra Industries, Inc., Meriden, Connecticut, <i>A Practical Guide to High Count Rate Germanium Gamma Spectroscopy</i> , Application Note, August 1993, pp. 1-20.

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021204

EXAMINER	DATE CONSIDERED
*EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.	